

# R1173S Series Reliability Test Report

301173S0-Ver.A

FUNCTION : Voltage Regulator ICs  
 PACKAGE : HSOP-6J Lead free

| No. | TEST ITEM                                   | TEST CONDITION  | (*)PRE-CONDITION | TIME               | r/n  |
|-----|---|---|------------------|--------------------|------|
| 1   | High Temp. Operating Life                   | Ta=125°C VDD=Vopt max. Static                             | Non              | 1000h              | 0/32 |
| 2   | Temp. Humidity Bias                         | Ta=85°C RH=85% VDD=Vopt max. Static                       | (1)+(2)          | 1000h              | 0/22 |
| 3   | High Temp. Storage                          | Ta=125°C  | Non              | 1000h              | 0/22 |
| 4   | Low Temp. Storage                           | Ta=-55°C  | Non              | 1000h              | 0/22 |
| 5   | Temp. Humidity                              | Ta=85°C RH=85%  | (1)+(2)          | 1000h              | 0/22 |
| 6   | Temp. Cycle                                 | Ta=-55 to 125°C(30-5-30min)                               | (1)+(2)          | 100cycles          | 0/11 |
| 7   | Thermal Shock                               | Ta=-55 to 125°C(5min-10s-5min)                            | (1)+(2)          | 100cycles          | 0/11 |
| 8   | USPCBT                                      | Ta=125°C RH=85% 2X10 <sup>5</sup> Pa VDD=Vopt max. Static | (1)+(2)          | 100h               | 0/11 |
| 9   | USPCT                                       | Ta=125°C RH=85% 2X10 <sup>5</sup> Pa                      | (1)+(2)          | 100h               | 0/11 |
| 10  | Resistance To Soldering Heat(1)             | IR Reflow (See Fig.1)                                     | (1)              | 3times             | 0/88 |
| 11  | Resistance To Soldering Heat(2)             | Ta=350°C(only terminal)                                   | (1)              | 5s                 | 0/11 |
| 12  | Solderability by Solder Dip Method(1)       | Ta=235°C(Solder: Sn-37Pb)                                 | (3)              | 5s                 | 0/11 |
| 13  | Solderability by Solder Dip Method(2)       | Ta=245°C(Solder: Sn-3.0Ag-0.5Cu)                          | (3)              | 5s                 | 0/11 |
| 14  | Solderability by Wettting Balance Method(1) | Ta=235°C(Solder: Sn-37Pb)                                 | (3)              | Zero cross Time 3s | 0/5  |
| 15  | Solderability by Wettting Balance Method(2) | Ta=245°C(Solder: Sn-3.0Ag-0.5Cu)                          | (3)              | Zero cross Time 3s | 0/5  |
| 16  | ESD(1)                                      | C=200pF R=0 ohm ±200V                                     | Non              | 5times             | 0/11 |
| 17  | ESD(2)                                      | C=100pF R=1.5k ohm ±2.0kV                                 | Non              | 3times             | 0/11 |
| 18  | Latch-up                                    | Pulse Current Injecting Method ±100mA                     | Non              | Once               | 0/11 |

Criteria : The electrical characteristics prescribed in the individual specifications shall be satisfied.

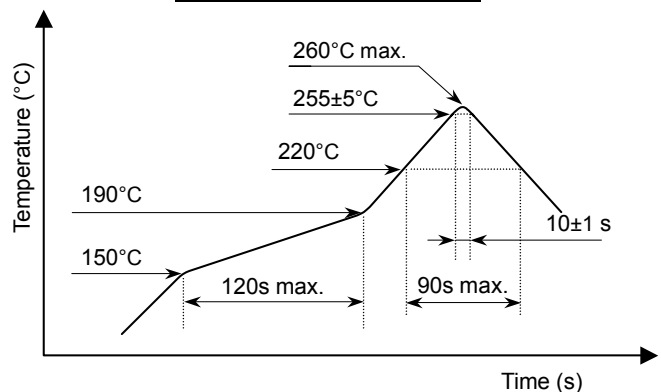
**\*)Pre-Condition**

The test shall be performed this pre-condition before testing.

- (1) Ta=85°C, RH=85%, storage 168h
- (2) IR Reflow soldering heat stress (3times)
- (3) In steam, storage=4h

[Moisture Sensitivity Level]  
 MSL Level = 1 (J-STD-020)

HEATING TREATMENT CONDITION OF INFRARED-RAY REFLOW



**Conclusion** : We have good results of reliability test.